### SN54ABT2952, SN74ABT2952 OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS

SCBS202 - NOVEMBER 1990 - REVISED OCTOBER 1992

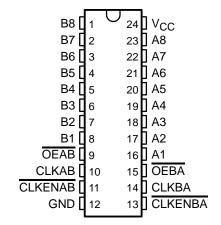
- State-of-the-Art EPIC-IIB™ BiCMOS Design Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Two 8-Bit Back-to-Back Registers Store Data Flowing in Both Directions
- Noninverting Outputs
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  1 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- Package Options Include Plastic Small-Outline (SOIC) and Shrink Small-Outline (SSOP) Packages, Ceramic Chip Carriers, and Plastic and Ceramic DIPs

### description

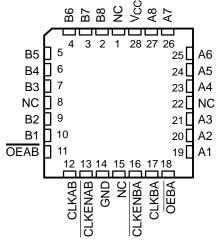
The 'ABT2952 consists of two 8-bit back-to-back registers that store data flowing in both directions between two bidirectional buses. Data on the A or B bus is stored in the registers on the low-to-high transition of the clock (CLKAB or CLKBA) input provided that the clock-enable (CLKENAB or CLKENBA) input is low. Taking the output-enable (OEAB or OEBA) input low accesses the data on either port.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

### SN54ABT2952 . . . JT PACKAGE SN74ABT2952 . . . DB, DW, OR NT PACKAGE (TOP VIEW)



SN54ABT2952 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The SN74ABT2952 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54ABT2952 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SN74ABT2952 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

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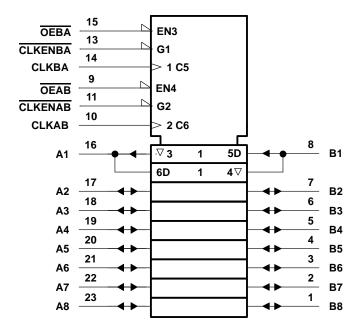
PRODUCT PREVIEW

### **FUNCTION TABLE**<sup>†</sup>

|         | OUTPUT     |      |   |                                      |
|---------|------------|------|---|--------------------------------------|
| CLKENAB | CLKAB      | OEAB | Α | В                                    |
| Н       | Х          | L    | Х | в <sub>0</sub> ‡                     |
| Х       | H or L     | L    | Χ | в <sub>0</sub> ‡<br>в <sub>0</sub> ‡ |
| L       | $\uparrow$ | L    | L | L                                    |
| L       | $\uparrow$ | L    | Н | Н                                    |
| Х       | Χ          | Н    | Χ | Z                                    |

<sup>†</sup> A-to-B data flow is shown; B-to-A data flow is similar but uses CLKENBA, CLKBA, and OEBA.

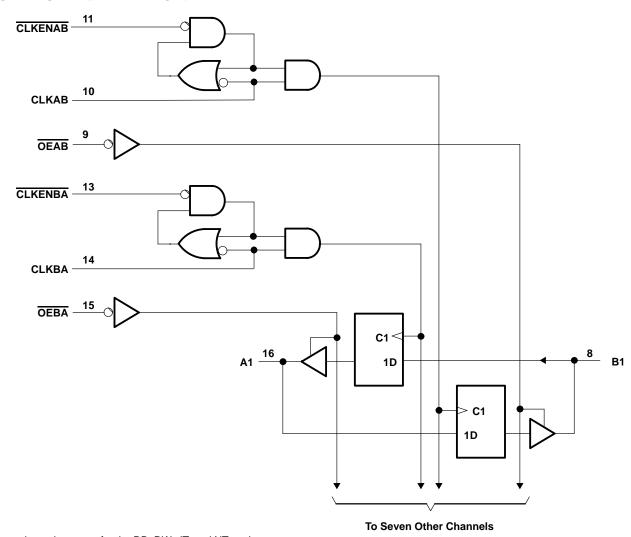
### logic symbol§



§ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DB, DW, JT, and NT packages.

<sup>‡</sup>Level of B before the indicated steady-state input conditions were established.

### logic diagram (positive logic)



Pin numbers shown are for the DB, DW, JT, and NT packages.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage range, V <sub>CC</sub>                               | 0.5 V to 7 V                                     |
|---|--|
| Input voltage range, V <sub>I</sub> (except I/O ports) (see Note 1) | 0.5 V to 7 V                                     |
| Voltage range applied to any output in the high state or            | r power-off state, V <sub>O</sub> 0.5 V to 5.5 V |
| Current into any output in the low state, IO: SN54ABT2              | 2952 96 mA                                       |
| SN74ABT2  | 2952   |
| Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)           | –18 mA   |
| Output clamp current, $I_{OK}$ ( $V_O < 0$ )                        | –50 mA   |
| Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air):    | DB package 0.7 W                                 |
|   | DW package 1 W                                   |
|   | NT package 1.3 W                                 |
| Storage temperature range   |  |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



## SN54ABT2952, SN74ABT2952 **OCTAL BUS TRANSCEIVERS AND REGISTERS** WITH 3-STATE OUTPUTS

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### recommended operating conditions (see Note 2)

|                                |  |                 |     |     | SN74AB | UNIT |      |
|--------------------------------|--|-----------------|-----|-----|--------|------|------|
|                                |  |                 | MIN | MAX | MIN    | MAX  | UNIT |
| V <sub>CC</sub> Supply voltage |  |                 |     | 5.5 | 4.5    | 5.5  | V    |
| VIH                            | V <sub>IH</sub> High-level input voltage |                 |     |     | 2      |      | V    |
| VIL                            | L Low-level input voltage                |                 |     |     |        | 0.8  | V    |
| VI                             | V <sub>I</sub> Input voltage             |                 |     |     | 0      | Vcc  | V    |
| ІОН                            | IOH High-level output current            |                 |     |     |        | -32  | mA   |
| loL                            | OL Low-level output current              |                 |     |     |        | 64   | mA   |
| Δt/Δν                          | Input transition rise or fall rate       | Outputs enabled |     | 10  |        | 10   | ns/V |
| TA                             | Operating free-air temperature           |                 |     | 125 | -40    | 85   | °C   |

NOTE 2: Unused or floating pins (input or I/O) must be held high or low.

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| DADAMETED          | TEST CONDITIONS   |                                    |                  | 7   | Γ <sub>A</sub> = 25°( | 2     | SN54ABT2952 |      | SN74ABT2952 |      |      |  |
|--------------------|---|------------------------------------|------------------|-----|-----------------------|-------|-------------|------|-------------|------|------|--|
| PARAMETER          |   |                                    |                  | MIN | TYP <sup>†</sup>      | MAX   | MIN         | MAX  | MIN         | MAX  | UNIT |  |
| ٧ıĸ                | $V_{CC} = 4.5 \text{ V}, \qquad I_{I} = -18 \text{ mA}$               |                                    |                  |     |                       | -1.2  |             | -1.2 |             | -1.2 | V    |  |
|                    | $V_{CC} = 4.5 \text{ V}, \qquad I_{OH} = -3 \text{ mA}$               |                                    |                  | 2.5 |                       |       | 2.5         |      | 2.5         |      |      |  |
| Varia              | V <sub>CC</sub> = 5 V, I <sub>OH</sub> = -3 mA                        |                                    |                  | 3   |                       |       | 3           |      | 3           |      | V    |  |
| VOH                | $V_{CC} = 4.5 \text{ V},$   | I <sub>OH</sub> = -24              | ł mA             | 2   |                       |       | 2           |      |             |      | V    |  |
|                    | $V_{CC} = 4.5 \text{ V},$   | I <sub>OH</sub> = - 32             | 2 mA             | 2‡  |                       |       |             |      | 2           |      |      |  |
| Voi                | $V_{CC} = 4.5 \text{ V},$   | I <sub>OL</sub> = 48 r             | nA               |     |                       | 0.55  |             | 0.55 |             |      | V    |  |
| VOL                | $V_{CC} = 4.5 \text{ V},$   | I <sub>OL</sub> = 64 r             | nA               |     |                       | 0.55‡ |             |      |             | 0.55 | V    |  |
| 1.                 | V <sub>CC</sub> = 5.5 V,<br>V <sub>I</sub> = V <sub>CC</sub> or GND   |                                    | Control inputs   |     |                       | ±1    |             | ±1   |             | ±1   |      |  |
| ΙĮ                 |   |                                    | A or B ports     |     |                       | ±100  |             | ±100 |             | ±100 | μΑ   |  |
| IOZH <sup>§</sup>  | $V_{CC} = 5.5 \text{ V}, \qquad V_{O} = 2.7 \text{ V}$                |                                    |                  |     |                       | 50    |             | 50   |             | 50   | μΑ   |  |
| I <sub>OZL</sub> § | V <sub>CC</sub> = 5.5 V,  | V <sub>O</sub> = 0.5 \             | J                |     |                       | -50   |             | -50  |             | -50  | μΑ   |  |
| I <sub>off</sub>   | $V_{CC} = 0$ ,  | V <sub>I</sub> or V <sub>O</sub> ≤ | 4.5 V            |     |                       | ±100  |             |      |             | ±100 | μΑ   |  |
| ICEX               | V00 = 5.5 V   |                                    | Outputs high     |     |                       | 50    |             | 50   |             | 50   | μΑ   |  |
| ΙΟ <sup>¶</sup>    | $V_{CC} = 5.5 \text{ V},$   | $V_0 = 2.5$                        | J                | -50 | -100                  | -180  | -50         | -180 | -50         | -180 | mA   |  |
|                    | $V_{CC} = 5.5 \text{ V},$   | A or B                             | Outputs high     |     | 1                     | 250   |             | 250  |             | 250  | μΑ   |  |
| <sup>I</sup> CC    | $I_{O} = 0$ ,   |                                    | Outputs low      |     | 24                    | 35    |             | 35   |             | 35   | mA   |  |
|                    | $V_I = V_{CC}$ or GND $P^C$   | Ports                              | Outputs disabled |     | 0.5                   | 250   |             | 250  |             | 250  | μΑ   |  |
| ∆l <sub>CC</sub> # | $V_{CC}$ = 5.5 V, One input at 3.4 V, Other inputs at $V_{CC}$ or GND |                                    |                  |     | 1.5                   |       | 1.5         |      | 1.5         | mA   |      |  |
| C <sub>i</sub>     | V <sub>I</sub> = 2.5 V or 0.5 V Control inputs                        |                                    |                  | 3.5 |                       |       |             |      |             | рF   |      |  |
| C <sub>io</sub>    | $V_O = 2.5 \text{ V or } 0.5 \text{ V}$ A or B ports                  |                                    |                  | 7.5 |                       |       |             |      |             | pF   |      |  |

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ .



<sup>‡</sup> On products compliant to MIL-STD-883, Class B, this parameter does not apply.

<sup>§</sup> The parameters IOZH and IOZL include the input leakage current.

<sup>¶</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

<sup>#</sup>This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

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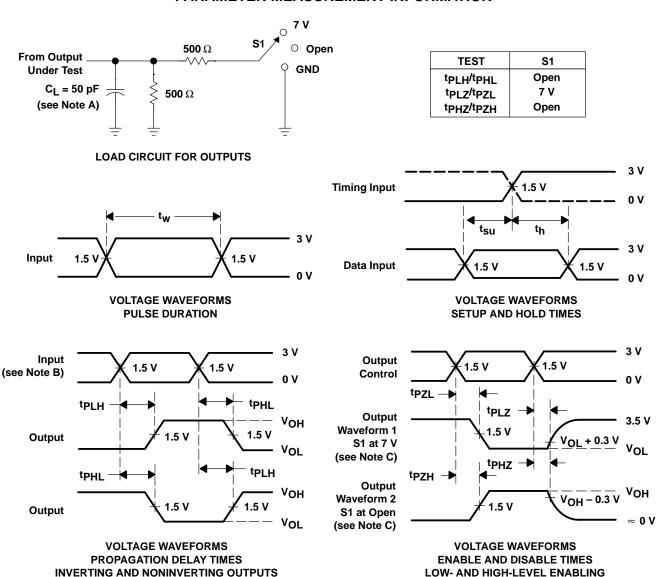
# timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

|                          |  |        |          | V <sub>CC</sub> = 5 V,<br>T <sub>A</sub> = 25°C |     | SN54ABT2952 |     | SN74ABT2952 |     | UNIT |
|--------------------------|--|--------|----------|---|-----|-------------|-----|-------------|-----|------|
|                          |  |        |          | MIN   | MAX | MIN         | MAX | MIN         | MAX |      |
| fclock                   | Clock frequency                        |        |          | 0   | 150 | 0           | 150 | 0           | 150 | MHz  |
| A Didea direction        |  |        | CLK high | 3   |     | 3           |     | 3           |     | 20   |
| ι <sub>W</sub>           | t <sub>W</sub> Pulse duration          |        | CLK low  | 3.5   |     | 3.5         |     | 3.5         |     | ns   |
|                          |  | A or B | High     | 4   |     | 4           |     | 4           |     |      |
| ١.                       | Catum tima hafana CLIKA                | AOIB   | Low      | 3   |     | 3           |     | 3           |     | no   |
| <sup>t</sup> su          | t <sub>SU</sub> Setup time before CLK↑ | OLIVEN | High     | 3.5   |     | 3.5         |     | 3.5         |     | ns   |
|                          |  | CLKEN  | Low      | 2.5   |     | 2.5         |     | 2.5         |     |      |
| 4.                       | Hold time after CLK↑                   | A or B | A or B   |   |     | 0           |     | 0           |     |      |
| t <sub>h</sub> Hold time | Hold time after CLK I                  |        |          | 0   |     | 0           |     | 0           |     | ns   |

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

| PARAMETER        | FROM<br>(INPUT) | TO<br>(OUTPUT)    | V <sub>CC</sub> = 5 V,<br>T <sub>A</sub> = 25°C |     |     | SN54ABT2952 |     | SN74ABT2952 |     | UNIT |
|------------------|-----------------|-------------------|---|-----|-----|-------------|-----|-------------|-----|------|
|                  |                 |                   | MIN   | TYP | MAX | MIN         | MAX | MIN         | MAX |      |
| f <sub>max</sub> |                 |                   | 150   |     |     | 150         |     | 150         |     | MHz  |
| t <sub>PLH</sub> | CLKAB or CLKBA  | B or A            |   |     |     |             |     |             |     | ns   |
| <sup>t</sup> PHL | CLNAB OF CLNBA  |                   |   |     |     |             |     |             |     |      |
| <sup>t</sup> PZH | OEBA or OEAB    | BA or OEAB A or B |   |     |     |             |     |             |     | ns   |
| <sup>t</sup> PZL | OEBA OI OEAB    | A 01 B            |   |     |     |             |     |             |     | 115  |
| <sup>t</sup> PHZ | OEBA or OEAB    | A or B            |   |     |     |             |     |             | ·   | ns   |
| tPLZ             | OLDA OI OLAD    |                   |   |     |     |             |     |             |     | 115  |

### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 2.5$  ns.  $t_f \leq 2.5$  ns.

**LOW- AND HIGH-LEVEL ENABLING** 

- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



PRODUCT PREVIEW

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